## Notice of References Cited Application/Control No. 10/766,244 Examiner Sanh D. Phu Applicant(s)/Patent Under Reexamination LI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,452,964	09-2002	Yoshida, Makoto	375/222
*	В	US-6,154,489	11-2000	Kleider et al.	375/221
*	С	US-2003/0231706	12-2003	Hwang, In Tae	375/219
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	7	US-			
	Κ	US-			
T I	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0			•		
	Р					9 9 1
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

	HON-I ATENT BOOGINENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.